

N-Channel Enhancement Mode MOSFET

Feature

100V/15A

 $R_{DS(ON)}=80 \text{ m}\Omega \text{ (typ.)} @ V_{GS} = 10V$

 $R_{DS(ON)}=125m\Omega$ (typ.) @ V_{GS} = 4.5V

- 100% Avalanche Tested
- Reliable and Rugged
- Halogen-Free and Green Devices Available (RoHS Compliant)

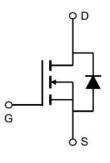
Pin Description



TO-252-2L

Applications

- Power Switching application
- Hard switched and high frequency circuits



N-Channel MOSFET

Ordering and Marking Information



Package Code

D:TO-252-2L

Date Code

XYMXXXXXX

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Unit | |
|-------------------|---|----------|------------|------|
| Common Rat | ings (Tc=25°C Unless Otherwise Noted) | | | |
| VDSS | Drain-Source Voltage | | 100 | V |
| Vgss | Gate-Source Voltage | | ±20 | V |
| TJ | Maximum Junction Temperature | | 175 | °C |
| Тѕтс | Storage Temperature Range | | -55 to 175 | °C |
| ls | Source Current-Continuous(Body Diode) Tc=25°C | | 32 | А |
| Mounted on L | arge Heat Sink | | , | |
| Iрм | Pulsed Drain Current * | Tc=25°C | 32 | Α |
| | O. History Brain Country | Tc=25°C | 15 | Α |
| lσ | Continuous Drain Current | Tc=100°C | 10.6 | Α |
| _ | | Tc=25°C | 51.7 | W |
| PD | P _D Maximum Power Dissipation Tc=100°C | | 25.8 | W |
| R ₀ JC | Thermal Resistance, Junction-to-Case | | 2.9 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient ** | | 110 | °C/W |
| Eas | Single Pulsed-Avalanche Energy *** L=0.3mH | | 9.71 | mJ |

Note: *

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

| Cumbal | Boromotor | Took Conditions | HYC | HYG101N10LA1 | | l lmit |
|--------------|----------------------------------|---|-----|--------------|------|--------|
| Symbol | Parameter | Test Conditions | Min | Тур. | Max | Unit |
| Static Cha | racteristics | | | | | |
| BVDSS | Drain-Source Breakdown Voltage | V _{GS} =0V,I _{DS} =250μA | 100 | - | - | V |
| lass | Drain to Source Leakage Current | V _{DS} =100V,V _{GS} =0V | - | - | 1.0 | μA |
| IDSS | Drain-to-Source Leakage Current | TJ=125°C | - | - | 50 | μA |
| $V_{GS(th)}$ | Gate Threshold Voltage | V _{DS} =V _{GS} , I _{DS} =250µA | 1.0 | 2.0 | 3.0 | V |
| Igss | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | - | - | ±100 | nA |
| RDS(ON)* | Drain-Source On-State Resistance | V _{GS} =10V,I _{DS} =10A | - | 80 | 100 | mΩ |
| RDS(ON)* | Drain-Source On-State Resistance | V _{GS} =4.5V,I _{DS} =7A | - | 125 | 150 | mΩ |
| Diode Cha | Diode Characteristics | | | | | |
| Vsp* | Diode Forward Voltage | Isp=10A,Vgs=0V | - | 0.8 | 1.3 | V |
| trr | Reverse Recovery Time | lon=10.4 dlon/dt=100.4/us | _ | 26.8 | - | ns |
| Qrr | Reverse Recovery Charge | - Isb=10A,dIsb/dt=100A/μs | - | 34.5 | - | nC |

^{*} Repetitive rating; pulse width limited by max. junction temperature.

^{**} Surface mounted on FR-4 board.

^{***} Limited by TJmax , starting TJ=25°C, L = 0.3mH, VDS=80V, VGS =10V.

HYG101N10LA1D



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

| Compleal | D | Test Conditions | HY | HYG101N10LA1 | | 11 |
|----------------|------------------------------|--|-----|--------------|-----|------|
| Symbol | Symbol Parameter Test Co | | Min | Тур. | Max | Unit |
| Dynamic | Characteristics | · | · | • | • | |
| R _G | Gate Resistance | V_{GS} =0V, V_{DS} =0V, F=1MHz | - | 3.1 | - | Ω |
| Ciss | Input Capacitance | Vgs=0V, | - | 1072 | - | |
| Coss | Output Capacitance | V _{DS} =25V, | - | 62 | - | pF |
| Crss | Reverse Transfer Capacitance | Frequency=1.0MHz | - | 15 | - | |
| td(ON) | Turn-on Delay Time | | - | 8.5 | - | |
| Tr | Turn-on Rise Time | V_{DD} =50 V , R_{G} =4 Ω , | - | 21.8 | - | |
| td(OFF) | Turn-off Delay Time | IDS=10A,VGS=10V | - | 23.4 | - | ns |
| Tf | Turn-off Fall Time | | - | 24.9 | - | |
| Gate Cha | rge Characteristics | | | | • | |
| Qg | Total Gate Charge | \/ -00\/ \/ -40\/ | - | 26 | _ | |
| Qgs | Gate-Source Charge | V_{DS} =80V, V_{GS} =10V, | - | 6 | _ | nC |
| Qgd | Gate-Drain Charge | ID-10A | - | 8 | _ | |

Note: *Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%



Typical Operating Characteristics

Figure 1: Power Dissipation

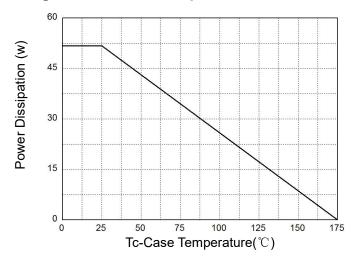


Figure 2: Drain Current

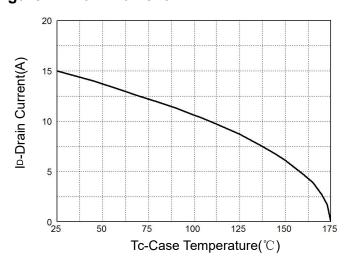


Figure 3: Safe Operation Area

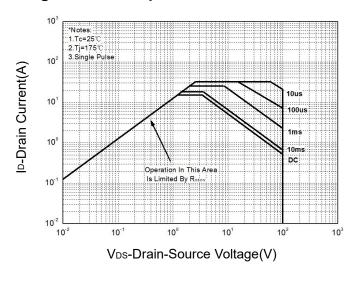
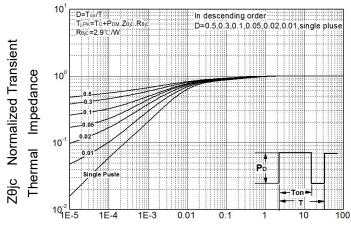


Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal

Impedance, Junction-to-Case

Figure 5: Output Characteristics Figure 6: D

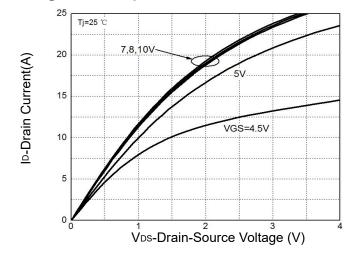
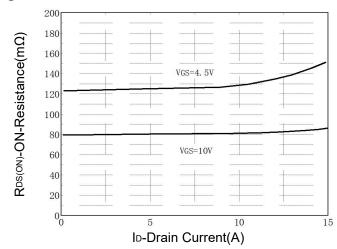


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

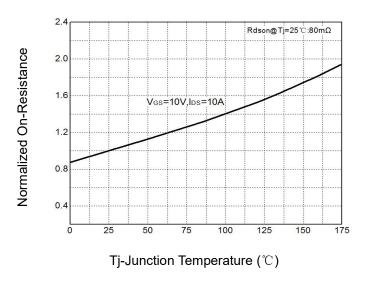


Figure 8: Source-Drain Diode Forward

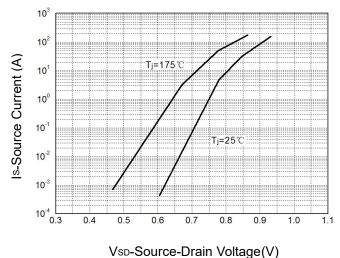


Figure 9: Capacitance Characteristics

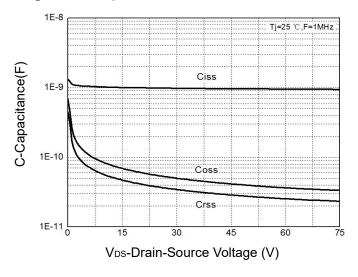
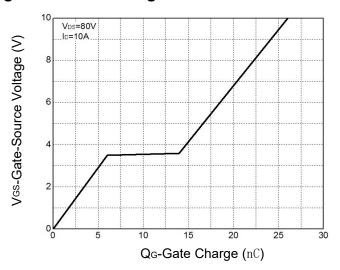
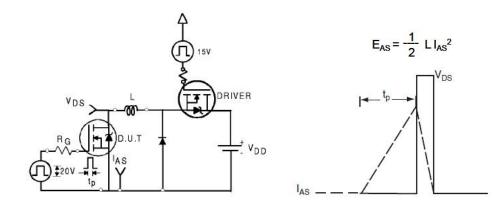


Figure 10: Gate Charge Characteristics

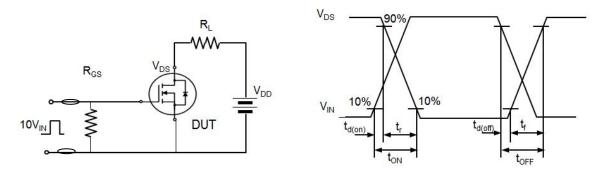




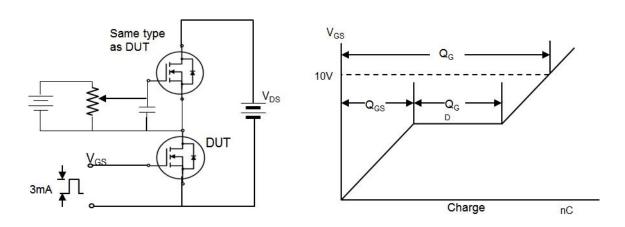
Avalanche Test Circuit



Switching Time Test Circuit



Gate Charge Test Circuit



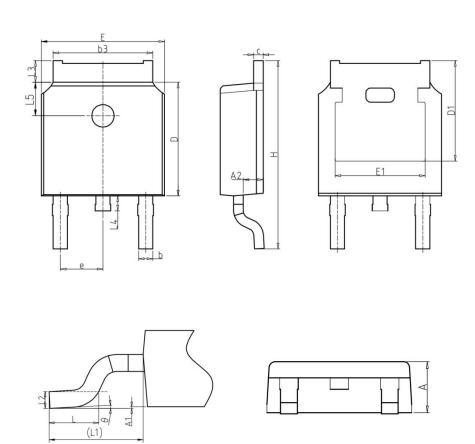


Device Per Unit

| Package Type | Unit | Quantity |
|--------------|------|----------|
| TO-252-2L | Reel | 2500 |

Package Information

TO-252-2L

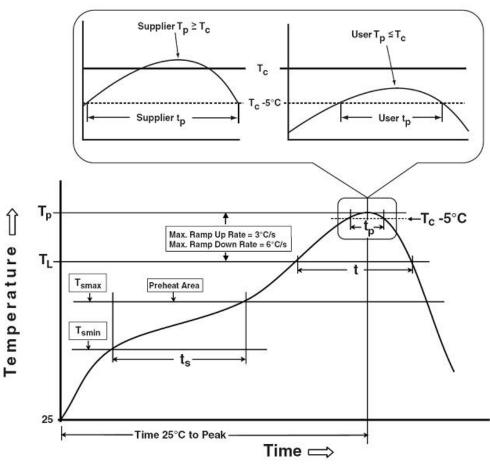


COMMON DIMENSIONS

| | mm | | | |
|--------|---------|----------|-------|--|
| SYMBOL | MIN | NOM | MAX | |
| | | | | |
| A | 2.20 | 2.30 | 2.40 | |
| A1 | 0.00 | - | 0.20 | |
| A2 | 0.97 | 1.07 | 1.17 | |
| b | 0.68 | 0.78 | 0.90 | |
| b3 | 5.20 | 5.33 | 5.50 | |
| С | 0.43 | 0.53 | 0.63 | |
| D | 5.98 | 6.10 | 6.22 | |
| D1 | 5.30REF | | | |
| E | 6.40 | 6.60 | 6.80 | |
| E1 | 4.63 | - | - | |
| е | | 2.286BS0 | 2 | |
| Н | 9.40 | 10.10 | 10.50 | |
| L | 1.38 | 1.50 | 1.75 | |
| L1 | | 2.90REF | | |
| L2 | 0.51BSC | | | |
| L3 | 0.88 | - | 1.28 | |
| L4 | - | - | 1.00 | |
| L5 | 1.65 | 1.80 | 1.95 | |
| θ | 0° | - | 8° | |



Classification Profile



Classification Reflow Profiles

| Profile Feature | Sn-Pb Eutectic Assembly | Pb-Free Assembly | |
|--|------------------------------------|----------------------------------|--|
| Preheat & Soak | 100 °C | 150 °C | |
| Temperature min (T _{smin}) | 150 °C | 200 °C | |
| Temperature max (T _{smax}) | 60-120 seconds | 60-120 seconds | |
| Time (Tsmin to Tsmax) (t _s) | 00-120 Seconds | 00-120 Seconds | |
| Average ramp-up rate | 3 °C/second max. | 3°C/second max. | |
| (T _{smax} to T _P) | 5 C/second max. | | |
| Liquidous temperature (T _L) | 183 °C | 217 °C | |
| Time at liquidous (t₋) | 60-150 seconds | 60-150 seconds | |
| Peak package body Temperature | See Classification Temp in table 1 | SeeClassification Tempin table 2 | |
| (T _p)* | See Classification Temp in table 1 | | |
| Time (t _P)** within 5°C of the specified | 20** seconds | 30** seconds | |
| classification temperature (T _c) | 20 seconds | | |
| Average ramp-down rate (Tpto Tsmax) | 6 °C/second max. | 6 °C/second max. | |
| Time 25°C to peak temperature | 6 minutes max. | 8 minutes max. | |
| *Tolerance for peak profile Temperature (T ₀) is defined as a supplier minimum and a user maximum. | | | |

Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

HYG101N10LA1D



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

| Package | Volume mm³ | Volume mm³ |
|-----------|------------|------------|
| Thickness | <350 | ≥350 |
| <2.5 mm | 235 °C | 220 °C |
| ≥2.5 mm | 220 °C | 220 °C |

Table 2.Pb-free Process – Classification Temperatures (Tc)

| Package | Volume mm³ | Volume mm³ | Volume mm³ |
|-----------------|------------|------------|------------|
| Thickness | <350 | 350-2000 | ≥2000 |
| <1.6 mm | 260 °C | 260 °C | 260 °C |
| 1.6 mm – 2.5 mm | 260 °C | 250 °C | 245 °C |
| ≥2.5 mm | 250 °C | 245 °C | 245 °C |

Reliability Test Program

| Test item | Method | Description |
|---------------|---------------|---------------------------------------|
| SOLDERABILITY | JESD-22, B102 | 5 Sec, 245°C |
| PRECON | JESD-22, A113 | 30°C/60%/192Hrs |
| HTRB | JESD-22, A108 | 168/500/1000 Hrs, Bias @ 150°C |
| HTGB | JESD-22, A108 | 168 Hrs/500hr/1000hr, Vgs100% @ 150°C |
| PCT | JESD-22, A102 | 96 Hrs, 100%RH, 2atm, 121°C |
| TCT | JESD-22, A104 | 500 Cycles, -55°C~150°C |

Customer Service

Worldwide Sales and Service: sales@hymexa.com Technical Support: Technology@hymexa.com

Huayi Microelectronics Co., Ltd.

No.8928, Shangji Road, Economic and Technological Development Zone, Xi'an, China

TEL: (86-029) 86685706 FAX: (86-029) 86685705 E-mail: sales@hymexa.com Web net: www.hymexa.com